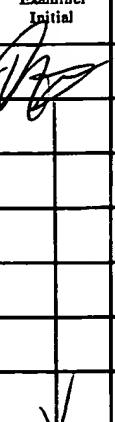
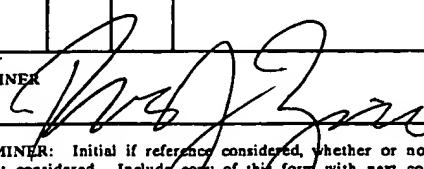
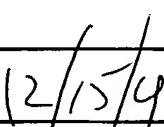
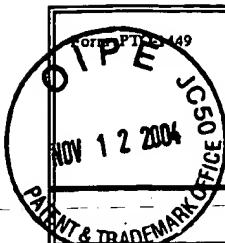


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					APPLICANT Craig M. Carpenter et al			
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<b>U.S. PATENT DOCUMENTS</b>								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA	6,228,563	5/01	Starov et al.	430	327		
	AB	6,333,268	12/01	Starov et al.	438	691		
	AC	4,872,947	10/89	Wang et al.	216	38		
	AD	5,000,113	3/91	Wang et al.	118	724E		
	AE	5,362,526	11/94	Wang et al.	427	573		
	AF	2003/0045098	3/03	Verhaeverbeke et al.	438	689		
	AG	2002/0155632	10/02	Yamazaki et al.	438	29		
	AH							
	AI							
	AJ							
AK								
AL								
<b>FOREIGN PATENT DOCUMENTS</b>								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AM							
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	AO							
	AP							
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MI22-1559SERIAL NO.  
09/810,387APPLICANT  
Craig M. Carpenter et alFILING DATE  
March 15, 2001GROUP  
1763

## U.S. PATENT DOCUMENTS

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
MM	AA	5,522,934	06/1996	Suzuki et al	118	723AN	
	AB	5,620,523	04/1997	Maeda et al	118	723J4	
	AC	5,772,771	06/1998	Li et al	118	723J	
	AD	6,132,552	10/2000	Donohoe et al	166	346B3	
	AE	6,294,026	09/2001	Roithner et al	118	715	
	AF	6,453,992	09/2002	Kim	165	206	
	AG	5,792,272	08/1998	Van Os et al	118	723L	
	AH	2003/0033980	02/2003	Campbell et al	118	715	
MM	AJ	2004/0144310	07/2004	Campbell et al	118	715	
	AJ						
	AK						
	AL						

## FOREIGN PATENT DOCUMENTS

	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
MM	JP 61-5515		Japan				
AN							
AO							
AP							
AQ							

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

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